

STFW69N65M5 STW69N65M5

N-channel 650 V, 0.037 Ωtyp., 58 A MDmesh™ V Power MOSFET in TO-3PF and TO-247 packages

Datasheet - production data

Features

Order codes	V _{DSS} @ T _{Jmax}	R _{DS(on)} max	I _D
STFW69N65M5	710 V	< 0.045 Ω	58 A
STW69N65M5	710 V	V 0.040 32	50 / t

- Worldwide best R_{DS(on)} * area
- Higher V_{DSS} rating and high dv/dt capability
- Excellent switching performance
- 100% avalanche tested

Applications

■ Switching applications

Description

These devices are N-channel MDmesh™ V Power MOSFETs based on an innovative proprietary vertical process technology, which is combined with STMicroelectronics' well-known PowerMESH™ horizontal layout structure. The resulting product has extremely low onresistance, which is unmatched among siliconbased Power MOSFETs, making it especially suitable for applications which require superior power density and outstanding efficiency.

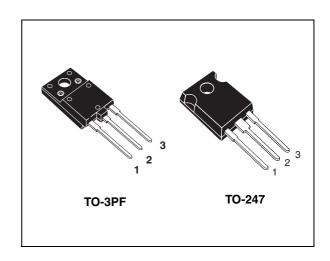


Figure 1. Internal schematic diagram

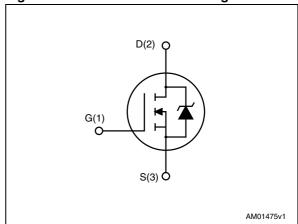


Table 1. Device summary

Order codes	Marking	Package	Packaging
STFW69N65M5	69N65M5	TO-3PF	Tube
STW69N65M5	CIVICONIEG	TO-247	Tube

September 2012 Doc ID 022906 Rev 2 1/16

This is information on a product in full production.

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Contents

1	Electrical ratings	3
2	Electrical characteristics	4
	2.1 Electrical characteristics (curves)	6
3	Test circuits	9
4	Package mechanical data	0
5	Revision history 1	15

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1 Electrical ratings

Table 2. Absolute maximum ratings

Cumbal	Barrantar	Va	l lmia	
Symbol	Parameter	TO-3PF	TO-247	Unit
V_{GS}	Gate-source voltage	±	25	V
I _D	Drain current (continuous) at T _C = 25 °C	58 ⁽¹⁾	58	Α
I _D	Drain current (continuous) at T _C = 100 °C	36.5 ⁽¹⁾	36.5	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	232 (1)	232	Α
P _{TOT}	Total dissipation at T _C = 25 °C	79	330	W
dv/dt (3)	Peak diode recovery voltage slope	1	15	
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1s; Tc=25°C)	3500		V
T _{stg}	Storage temperature - 55 to 150		°C	
Tj	Max. operating junction temperature	15	50	°C

- 1. Limited by maximum junction temperature.
- 2. Pulse width limited by safe operating area
- 3. $I_{SD} \le 58 \text{ A, di/dt } \le 400 \text{ A/}\mu\text{s; } V_{DS \text{ peak}} < V_{(BR)DSS,} V_{DD} = 400 \text{ V}$

Table 3. Thermal data

Symbol	Parameter	Val	Unit	
Symbol	raiametei	TO-3PF	TO-247	
R _{thj-case}	Thermal resistance junction-case max	1.58	0.38	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	50		°C/W

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetetive or not repetetive (pulse width limited by $T_{\rm jmax}$)	12	Α
E _{AS}	Single pulse avalanche energy (starting t_j =25°C, I_d = I_{AR} ; V_{dd} =50)	1410	mJ

2 Electrical characteristics

 $(T_C = 25 \, ^{\circ}C \text{ unless otherwise specified})$

Table 5. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	650			V
I _{DSS}		V _{DS} = 650 V V _{DS} = 650 V, T _C =125 °C			1 100	μ Α μ Α
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 25 \text{ V}$			± 100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 29 \text{ A}$		0.037	0.045	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 100 \text{ V, f} = 1 \text{ MHz,}$ $V_{GS} = 0$	-	6420 170 11	-	pF pF pF
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related	V _{DS} = 0 to 520 V, V _{GS} = 0	-	536	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	V _{DS} = 0 to 320 v, v _{GS} = 0	-	146	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz open drain	-	1.2	-	Ω
Qg	Total gate charge	$V_{DD} = 520 \text{ V}, I_D = 29 \text{ A},$		143		nC
Q_{gs}	Gate-source charge	V _{GS} = 10 V	-	38	-	nC
Q_{gd}	Gate-drain charge	(see Figure 18)		64		nC

^{1.} Time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

^{2.} Energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
t _{d(v)}	Voltage delay time	$V_{DD} = 400 \text{ V}, I_D = 38 \text{ A},$		102		ns
$t_{r(v)}$	Voltage rise time	$R_G = 4.7 \Omega$, $V_{GS} = 10 V$		13.5		ns
t _{f(i)}	Current fall time	(see <i>Figure 19</i> and	_	10	_	ns
t _{c(off)}	Crossing time	Figure 22)		19		ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)		-		58 232	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 58 A, V _{GS} = 0	-		1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 58 A, di/dt = 100 A/μs V _{DD} = 100 V (see <i>Figure 19</i>)	-	480 11 46		ns μC A
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 58 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 100 \text{ V}, T_j = 150 ^{\circ}\text{C}$ (see <i>Figure 19</i>)	-	592 16 53		ns μC A

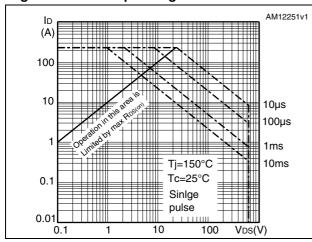
^{1.} Pulse width limited by safe operating area.

^{2.} Pulsed: pulse duration = $300 \mu s$, duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-3PF

Figure 3. Thermal impedance for TO-3PF



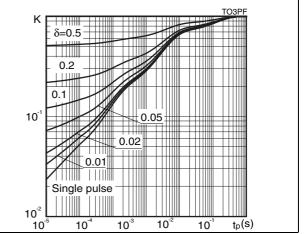
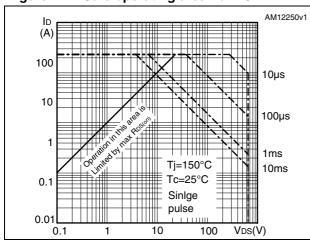


Figure 4. Safe operating area for TO-247

Figure 5. Thermal impedance for TO-247



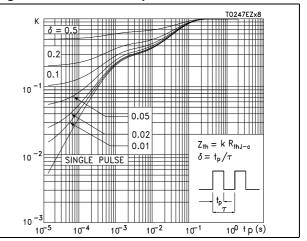
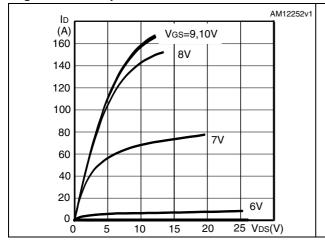


Figure 6. Output characteristics

Figure 7. Transfer characteristics



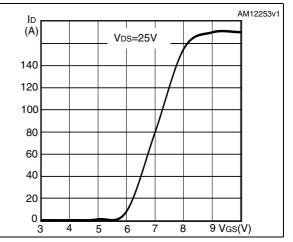
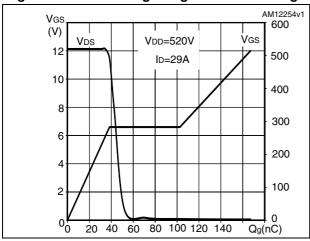


Figure 8. Gate charge vs gate-source voltage Figure 9. Static drain-source on-resistance



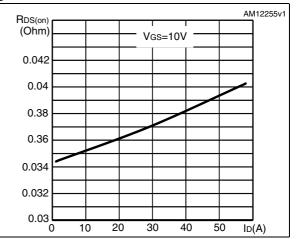
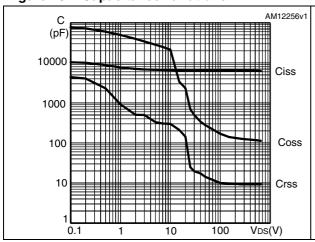


Figure 10. Capacitance variations

Figure 11. Output capacitance stored energy



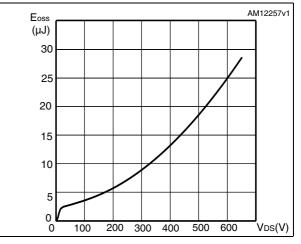
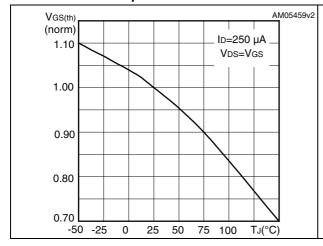


Figure 12. Normalized gate threshold voltage Figure 13. vs temperature

Figure 13. Normalized on-resistance vs temperature



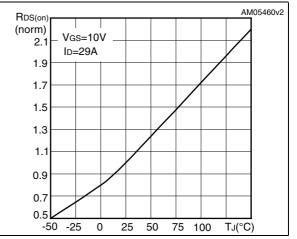
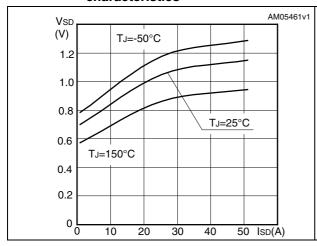


Figure 14. Source-drain diode forward characteristics

Figure 15. Normalized B_{VDSS} vs temperature



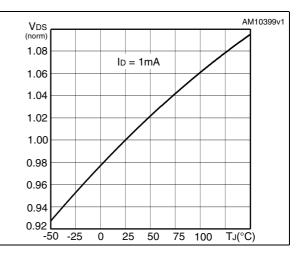
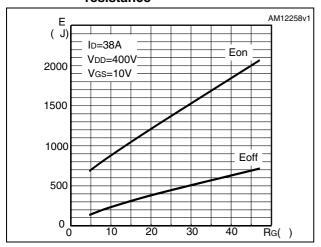


Figure 16. Switching losses vs gate resistance⁽¹⁾



1. Eon including reverse recovery of a SiC diode

3 Test circuits

Figure 17. Switching times test circuit for resistive load

Figure 18. Gate charge test circuit

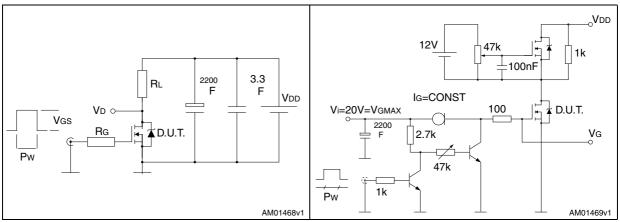


Figure 19. Test circuit for inductive load switching and diode recovery times

Figure 20. Unclamped inductive load test circuit

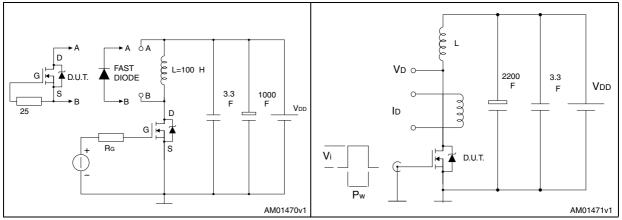
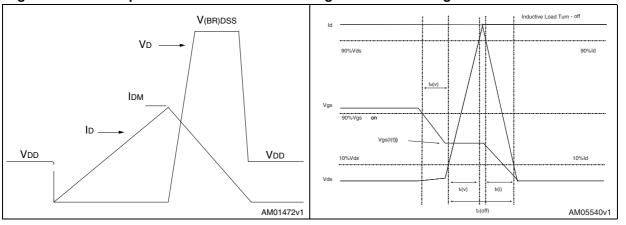


Figure 21. Unclamped inductive waveform

Figure 22. Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.

Table 9. TO-3PF mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	5.30		5.70
С	2.80		3.20
D	3.10		3.50
D1	1.80		2.20
Е	0.80		1.10
F	0.65		0.95
F2	1.80		2.20
G	10.30		11.50
G1		5.45	
Н	15.30		15.70
L	9.80	10	10.20
L2	22.80		23.20
L3	26.30		26.70
L4	43.20		44.40
L5	4.30		4.70
L6	24.30		24.70
L7	14.60		15
N	1.80		2.20
R	3.80		4.20
Dia	3.40		3.80

Figure 23. TO-3PF drawing

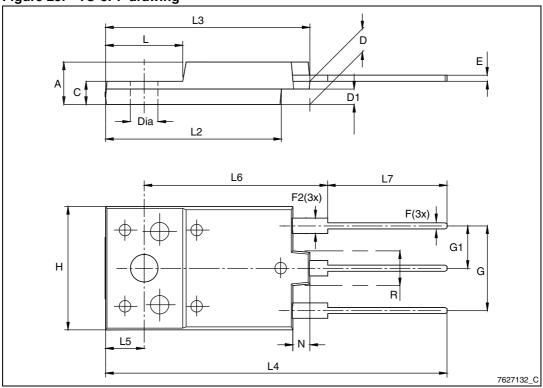
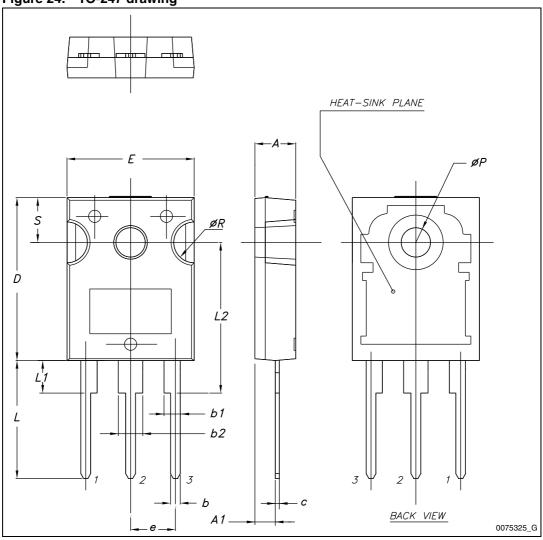


Table 10. TO-247 mechanical data

Dim		mm.	
Dim.	Min.	Тур.	Max.
Α	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
E	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

Figure 24. TO-247 drawing



5 Revision history

Table 11. Document revision history

Date	Revision	Changes
27-Feb-2012	1	First release.
28-Sep-2012	2	 Modified: note 3 of Table 2, values in Table 4, typ. values in Table 6, 7 and 8 Curves inserted Minor text changes

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